

Search Notes



Application/Control No.

10/665,482

Examiner

David Dunn

Applicant(s)/Patent under Reexamination

YOSHIKAWA ET AL.

Art Unit

3616

SEARCHED

Class	Subclass	Date	Examiner
280	729 730.1 730.2 752	9/1/2005	DD
280	743.1	2/15/06	DD
	743.2	↓	↓
UPDATED			
UPDATED ABOVE		5/22/06	DD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
280	729	5/22/06	DD
	730.1		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Interference Text search [FAST] see enclosed	5/22/06	DD